Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/485,146	HIRAIWA ET AL.
Examiner	Art Unit
John M. Frink	2142

SEARCHED				
Class	Subclass	Date	Examiner	
			,	

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
inventor search	9/20/2007	JMF	
text + date	9/20/2007	JMF	
assignee + text	9/20/2007	JMF	
subclass + text	9/20/2007	JMF	